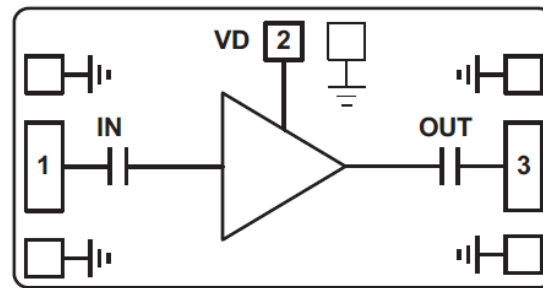


**Features**

- Gain: 9.5dB
- P1dB: +20dBm
- Psat: +22dBm
- Biasing +5V @ 105mA
- Impedance: 50Ω
- Die Size: 1.9 x 1.2 x 0.1 mm

**Functional Block Diagram**

**Typical Applications**

- Test Instrumentation
- Microwave Radio & VSAT
- Military & Space
- Telecom Infrastructure
- Fiber Optics

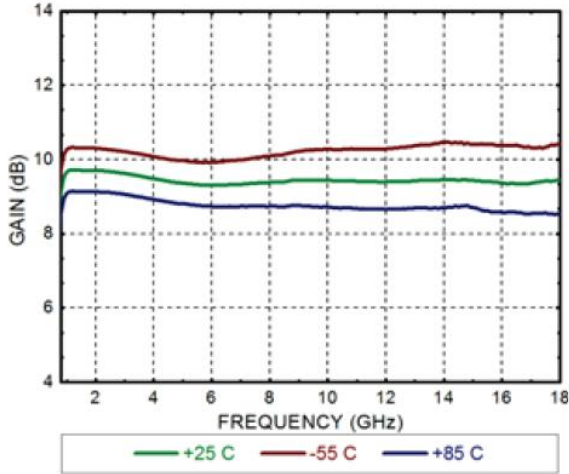
**Electrical Specifications**

TA = +25°C, Vdd = +5V Idd = 105mA

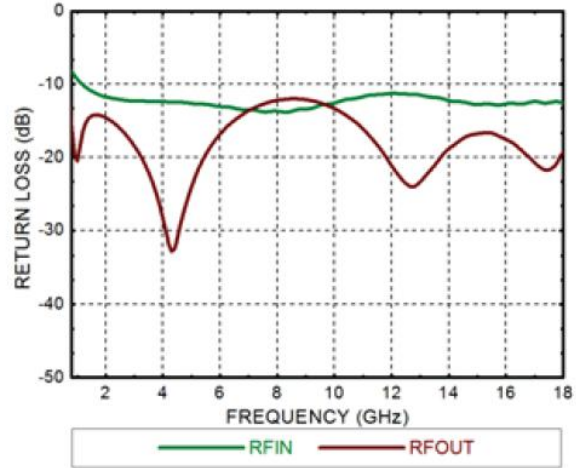
Parameters	Min.	Typ.	Max.	Min.	Typ.	Max.	Min.	Typ.	Max.	Units
Frequency	0.8 - 6			6 -12			12 -18			GHz
Gain		9.5			9.4			9.4		dB
Gain Flatness		±0.3			±0.1			±0.1		dB
Input Return Loss		10			12			12		dB
Output Return Loss		15			12			15		dB
Output 1dB Compression (P1dB)		21			20.5			19.5		dBm
Saturated Output Power (Psat)		23			22.5			21.5		dBm
Output Third Order Intercept (IP3)		29			28.5			27.5		dBm
Current	80	105	130	80	105	130	80	105	130	mA



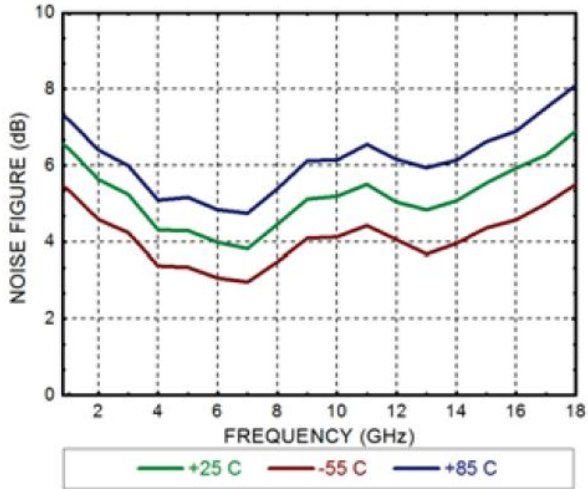
### Gain



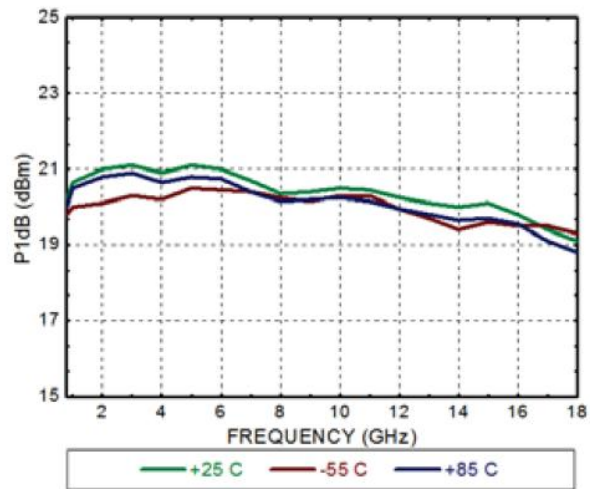
### Return Loss



### Noise Figure



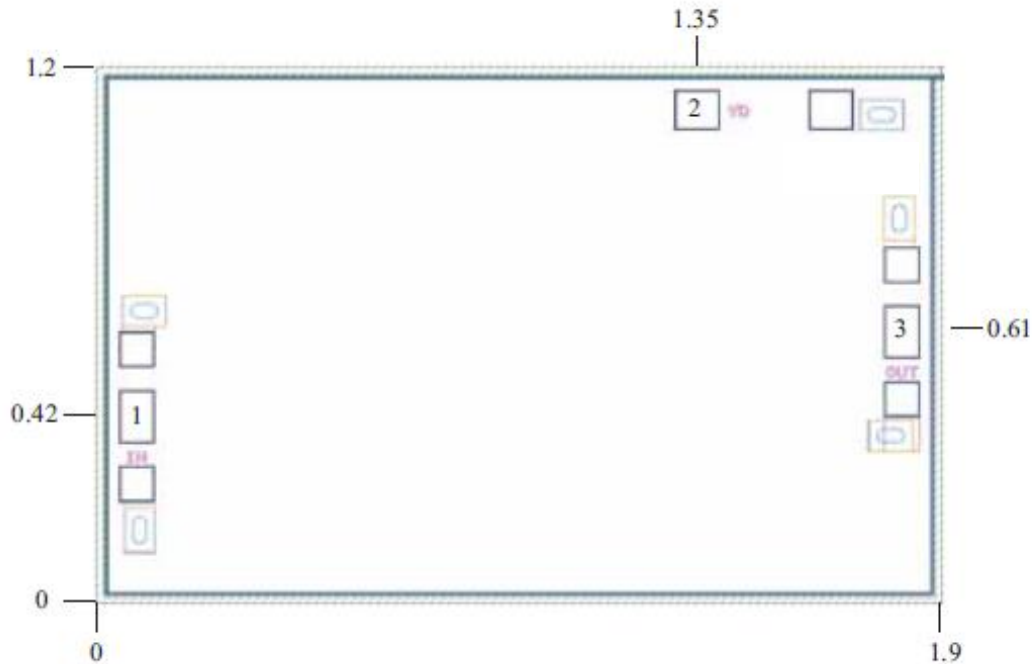
### Output Power $P_{1dB}$





### Outline Drawing:

All Dimensions in mm

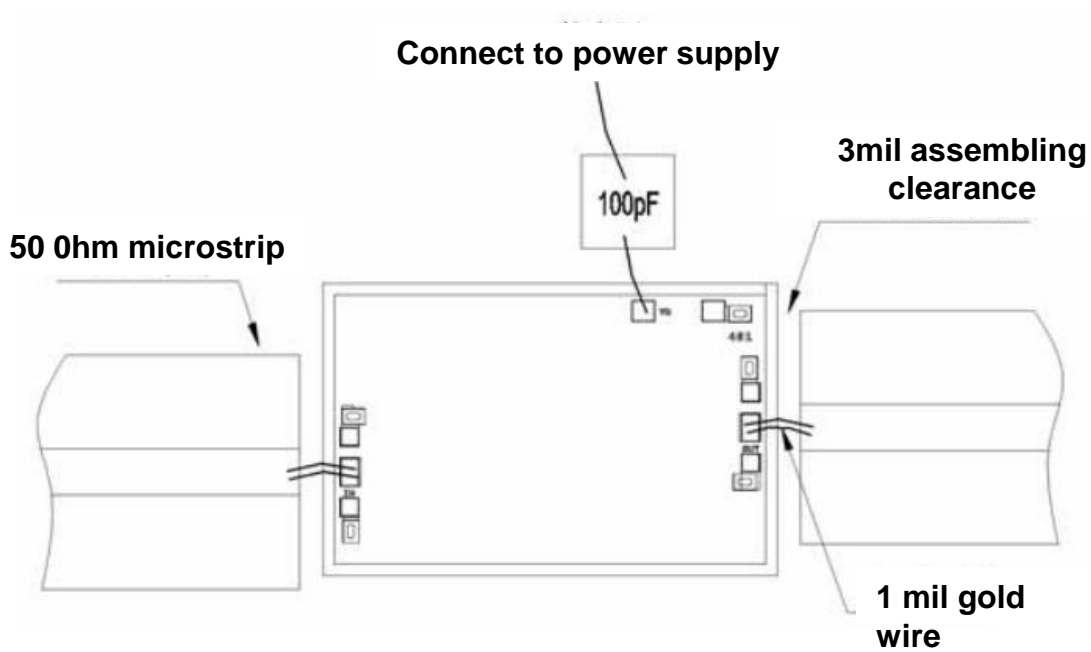


### Pad Description

PAD	Function	Description
1	IN	Input AC coupling 50Ω Impedance
2	VD	The pad provides the power voltage of the amplifier, which needs to be externally connected with the 100pF bypass capacitor, and the pad to the capacitor cascade is controlled within 600um.
3	OUT	Output AC coupling 50Ω Impedance
Die Bottom	GND	Die bottom must be connected to RF/DC ground



### Assembly Drawing



#### Notes:

1. Die thickness: 100um
2. Typical bond pad is 100\*100  $\mu\text{m}^2$
3. Bond pad metalization: Gold
4. Backside metalization: Gold
5. Backside of the die (GND)
6. No connection required for unlabeled bond pads

#### Maximum Ratings:

1. Power supply voltage: +6V
2. RF input power: +18dBm
3. Storage temperature: -65°C to +175°C
4. Operating temperature: -55°C to +85°C